


<b>Search Notes</b> 	<b>Application/Control No.</b> 10806980	<b>Applicant(s)/Patent Under Reexamination</b> CHEUNG ET AL.
	<b>Examiner</b> PHU NGUYEN	<b>Art Unit</b> 2628

SEARCHED			
Class	Subclass	Date	Examiner
345	419, 420, 424, 473, 474, 434, 848-861	11/8/10	pn

SEARCH NOTES		
Search Notes	Date	Examiner
WEST search: sampling probe, volume, 3D database, voxel	11/8/10	pn
NonPatent Literature: IEEE, ACM, Google	11/8/10	pn
Inventor Name search	11/8/10	pn

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
345	419, 420, 424, 473, 434, 848	11/8/10	pn

--	--